Notic of References Cit d Application/Control No. 10/625,879 Applicant(s)/Patent Under Reexamination TAMURA, HIROTAKA Examiner Hai L. Nguyen Applicant(s)/Patent Under Reexamination TAMURA, HIROTAKA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,606,365	08-2003	Chen, Dao-Long	375/376
	В	US-6,600,797	07-2003	Hasegawa et al.	375/376
	C	US-6,496,555	12-2002	Soda, Masaaki	375/376
	D	US-6,249,160	06-2001	Tagami et al.	327/165
	Е	US-6,236,697	05-2001	Fang, Al X.	375/376
	F	US-5,953,386	09-1999	Anderson, Michael B.	375/376
	G	US-5,483,180	01-1996	Chai et al.	326/93
	Н	US-5,323,242	06-1994	Yamamoto et al.	386/41
	-	US-5,075,639	12-1991	Taya, Takashi	331/2
	٦	US-			
	К	US-			
	٦	US-			
	Δ	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S	·				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		-
	V		
_	w		
	х		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.